Se	earcn No	otes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/717,178	HOFFMANN ET AL.
Examiner	Art Unit
Ly D. Pham	2827

	SEAR	CHED	
Class	Subclass	Date	Examiner
365	225.7, 96, 230.08, 239	10/21/2005	LP

TMI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
1	data base ries attached	10/21/2005	LP

SEARCH NOT (INCLUDING SEARCH)
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East text search	10/21/2005	LP
Interference search querires attached	10/21/2005	LP
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